DATA SHEET

MOS FIELD EFFECT TRANSISTOR

μ**PA2790GR**

SWITCHING N- AND P-CHANNEL POWER MOS FET

DESCRIPTION

JEC

The μ PA2790GR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

FEATURES

• Low on-state resistance

N-channel $R_{DS(on)1} = 28 \text{ m}\Omega \text{ MAX.}$ (VGs = 10 V, ID = 3 A) $R_{DS(on)2} = 40 \text{ m}\Omega \text{ MAX.}$ (VGs = 4.5 V, ID = 3 A) P-channel $R_{DS(on)1} = 60 \text{ m}\Omega \text{ MAX.}$ (VGs = -10 V, ID = -3 A)

 $R_{DS(on)2} = 80 \text{ m}\Omega \text{ MAX.} (V_{GS} = -4.5 \text{ V}, \text{ ID} = -3 \text{ A})$

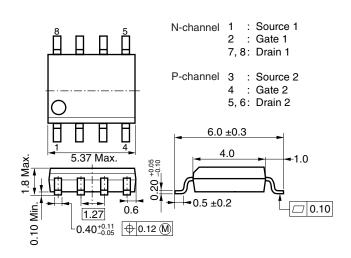
• Low input capacitance

N-channel Ciss = 500 pF TYP.

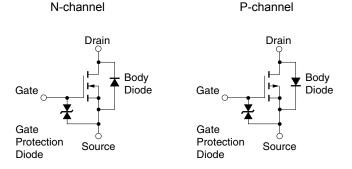
P-channel Ciss = 460 pF TYP.

- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUITS



ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA2790GR	Power SOP8

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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The mark \star shows major revised points.

 \star

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C. All terminals are connected.)

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT		
Drain to Source Voltage (V _{GS} = 0 V)	VDSS	30	-30	V		
Gate to Source Voltage (V _{DS} = 0 V)	Vgss	±20	∓20	V		
Drain Current (DC)	ID(DC)	±6	∓6	А		
Drain Current (pulse) Note1	D(pulse)	±24	∓24	А		
Total Power Dissipation (1 unit) Note2	Р⊤	1.7		W		
Total Power Dissipation (2 units) Note2	Р⊤	2.0		W		
Channel Temperature	Tch	150		150		°C
Storage Temperature	Tstg	–55 to +150		-55 to +150		°C
Single Avalanche Current Note3	las	6	-6	А		
Single Avalanche Energy Note3	Eas	3.6	3.6	mJ		

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

3. Starting T_{ch} = 25°C, V_{DD} =
$$\frac{1}{2}$$
 x V_{DSS}, R_G = 25 Ω , L = 100 μ H, V_{GS} = V_{GSS} \rightarrow 0 V

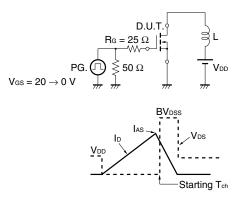
ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)

N-channel

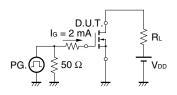
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	lgss	V _{GS} = ±16 V, V _{DS} = 0 V			±10	μA
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5		2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = 10 V, I _D = 3 A	2			S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = 10 V, I _D = 3 A		21	28	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 3 A		28	40	mΩ
	RDS(on)3	V _{GS} = 4.0 V, I _D = 3 A		34	53	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		500		pF
Output Capacitance	Coss	V _{GS} = 0 V		135		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		77		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 15 V, I _D = 3 A		9.2		ns
Rise Time	tr	V _{GS} = 10 V		8.8		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		28		ns
Fall Time	tr			7.4		ns
Total Gate Charge	QG	I _D = 6 A		12.6		nC
Gate to Source Charge	Q _{GS}	V _{DD} = 24 V		1.7		nC
Gate to Drain Charge	Qgd	V _{GS} = 10 V		3.8		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 6 A, VGS = 0 V		0.85		V
Reverse Recovery Time	trr	IF = 6 A, VGS = 0 V		18		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		11		nC

Note Pulsed

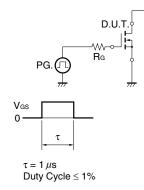
TEST CIRCUIT 1 AVALANCHE CAPABILITY

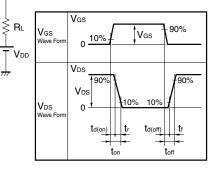


TEST CIRCUIT 3 GATE CHARGE



TEST CIRCUIT 2 SWITCHING TIME





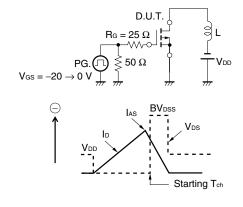
P-channel

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ibss	V _{DS} = -30 V, V _{GS} = 0 V			-10	μA
Gate Leakage Current	lgss	V _{GS} = ∓16 V, V _{DS} = 0 V			∓10	μA
Gate Cut-off Voltage	V _{GS(off)}	V_{DS} = -10 V, I _D = -1 mA	-1.0		-2.5	V
Forward Transfer Admittance Note	y _{fs}	$V_{DS} = -10 V$, $I_{D} = -3 A$	2			S
Drain to Source On-state Resistance ^{Note}	RDS(on)1	V _{GS} = -10 V, I _D = -3 A		43	60	mΩ
	RDS(on)2	V_{GS} = -4.5 V, I _D = -3 A		58	80	mΩ
	RDS(on)3	Vgs = -4.0 V, Id = -3 A		65	110	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		460		pF
Output Capacitance	Coss	V _{GS} = 0 V		130		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		77		pF
Turn-on Delay Time	t _{d(on)}	$V_{DD} = -15 V, I_D = -3 A$		8.5		ns
Rise Time	tr	V _{GS} = -10 V		4.8		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		42		ns
Fall Time	tr			19		ns
Total Gate Charge	QG	I _D = -6 A		11		nC
Gate to Source Charge	Q _{GS}	V _{DD} = -24 V		1.7		nC
Gate to Drain Charge	Qgd	V _{GS} = -10 V		3.3		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 6 A, VGS = 0 V		0.92		V
Reverse Recovery Time	trr	IF = 6 A, VGS = 0 V		21		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		12		nC

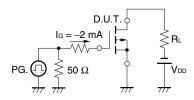
Note Pulsed

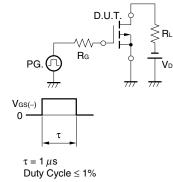
TEST CIRCUIT 1 AVALANCHE CAPABILITY

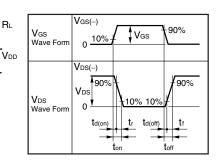
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE



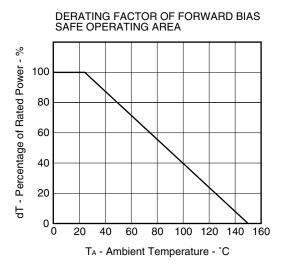




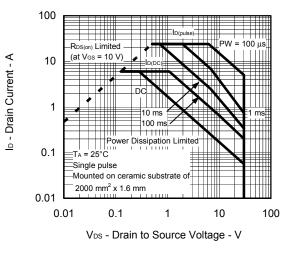
★ TYPICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)

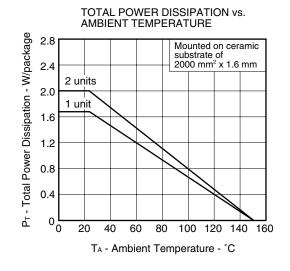
(1) N-channel

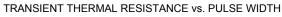
NEC

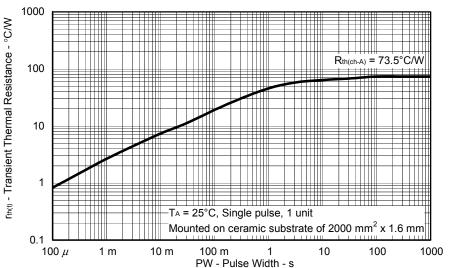


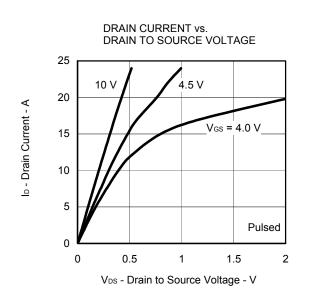




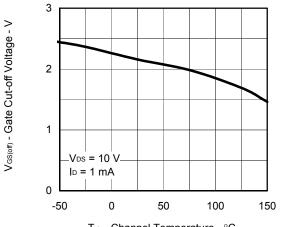


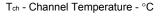


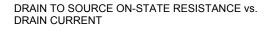


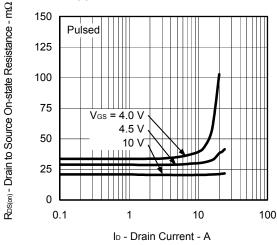




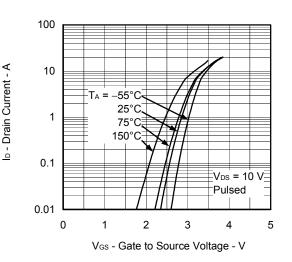




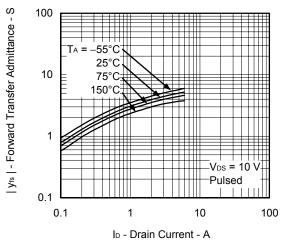




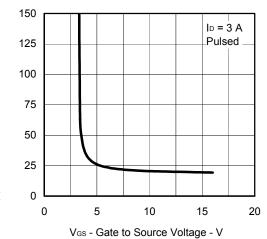
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

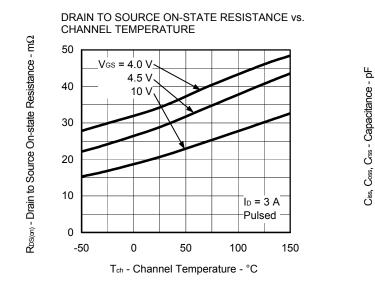


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

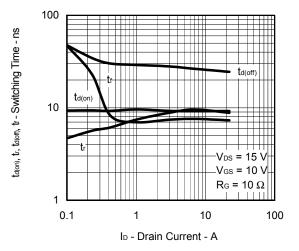


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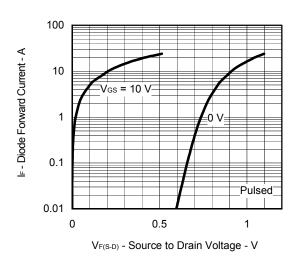
 $R_{DS(cn)}$ - Drain to Source On-state Resistance - m Ω

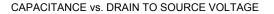


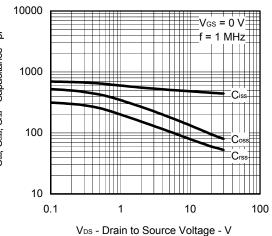
SWITCHING CHARACTERISTICS

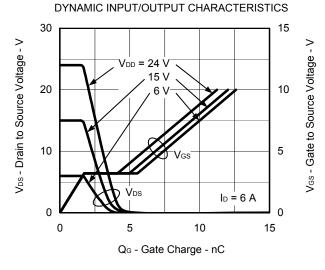


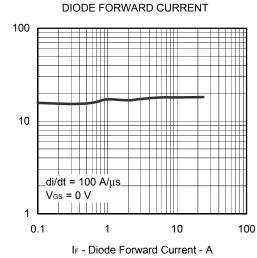
SOURCE TO DRAIN DIODE FORWARD VOLTAGE







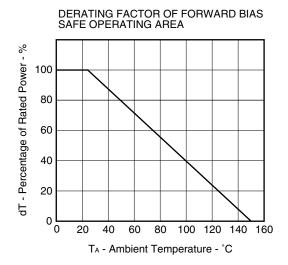




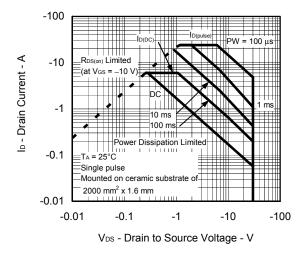
REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

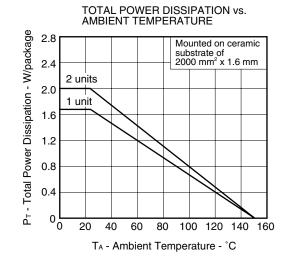
tr - Reverse Recovery Time - ns

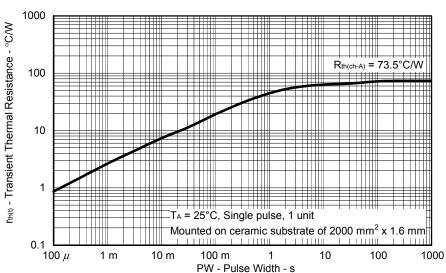
(2) P-channel



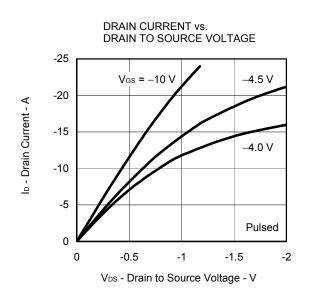
FORWARD BIAS SAFE OPERATING AREA



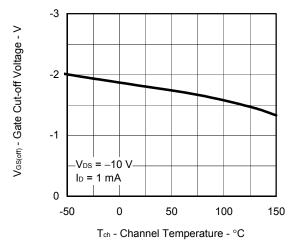


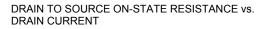


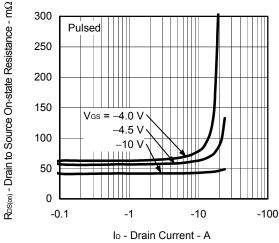
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



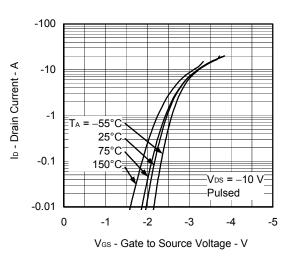




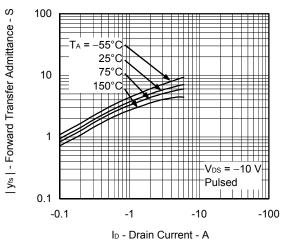




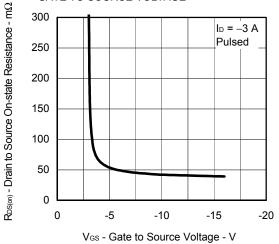
FORWARD TRANSFER CHARACTERISTICS

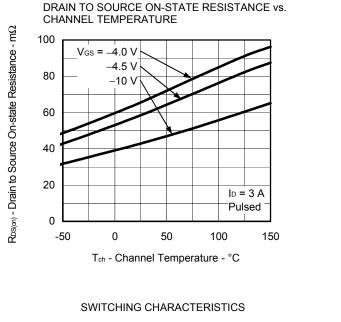


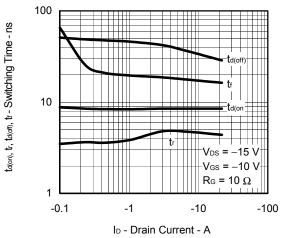
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



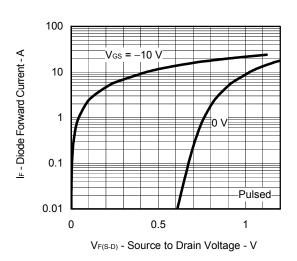
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



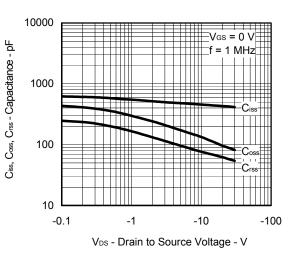




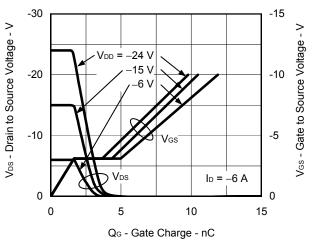
SOURCE TO DRAIN DIODE FORWARD VOLTAGE

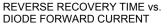


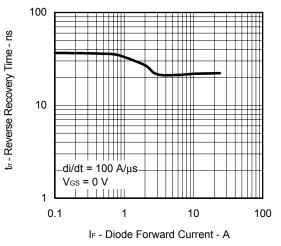
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS









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